


<b>Search Notes</b> 	<b>Application/Control No.</b> 10041633	<b>Applicant(s)/Patent Under Reexamination</b> KOBAYASHI ET AL.
	<b>Examiner</b> david shay	<b>Art Unit</b> 3735

SEARCHED			
Class	Subclass	Date	Examiner
606	3-7, 10-13	2/16/2008	dms
372	22-25	2/16/2008	dms

SEARCH NOTES		
Search Notes	Date	Examiner

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner